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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Hidekazu HOSHINO et al.

Application No.: 10/527,446

Filed: March 11, 2005

For: OBJECT IDENTIFYING MEDIUM USING MULTI-LAYER THIN-FILM



Group Art Unit: 2131

Examiner:

Docket No.: 123156

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the reference(s) listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the reference(s) be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- ☒ 1. This Information Disclosure Statement is being filed before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- ☒ 2. One or more reference cited herein was cited in a counterpart foreign application. An English language version of the foreign search report is attached for the Examiner's information.
- ☒ 3. In accordance with 37 CFR §1.98(a)(2)(ii), copies of any U.S. patents and patent application publications are not attached.
- ☒ 4. US RE38,321 corresponds to CN1123921 A, which is cited in the foreign search report.

Respectfully submitted,

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Date: March 27, 2006

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Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 123156		APPLICATION NO. 10/527,446	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANTS Hidekazu HOSHINO et al.			
				FILING DATE March 11, 2005		GROUP 2131	
U.S. PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Name			
	1.	RE38,321 E	11/28/2003	Haruo UYAMA et al.			
FOREIGN PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation	
OTHER DOCUMENTS							
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)					
EXAMINER				DATE CONSIDERED			
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: March 27, 2006